Application/Control No. O9/420,719 Applicant(s)/Patent Under Reexamination MIYASHITA ET AL. Examiner Kartic Padmanabhan Applicant(s)/Patent Under Reexamination MIYASHITA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
	Α	US-6,379,883	04-2002	Davis et al.	435/4		
	В	US-					
	С	US-					
	D	US-					
	E	US-					
	F	US-					
	G	US-					
	Н	US-					
	1	US-					
	J	US-					
	К	US-					
	L	US-					
	М	US-					

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.